

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/663,469	LANIER ET AL.	
	<b>Examiner</b> Felix E. Suarez	<b>Art Unit</b> 2857	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
702	117, 118	3/15/2006	FS
702	121, 122	3/15/2006	FS